## Notice of References Cited Application/Control No. 10/621,156 Examiner Dmitry Suhol Applicant(s)/Patent Under Reexamination WEINER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0142271 A1	10-2002	Curtin, Kazuko	434/167
	В	US-6,551,106 B1	04-2003	Sherin, John M.	434/259
	С	US-2002/0146676 A1	10-2002	Reynolds, Thomas J.	434/362
	D	US-2003/0118975 A1	06-2003	Stamm et al.	434/236
	Ε	US-5,741,137	04-1998	Aduvala, Prasad V	434/236
	F	US-2002/0009696 A1	01-2002	Lui et al.	434/171
	G	US-6,540,518 B1	04-2003	Shepherd, Kimberly A.	434/236
	Н	US-2001/0031450 A1	10-2001	Khan, Sajid A.M.	434/156
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ø				•	
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.